

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10/757,829	SHIRAISHI ET AL.
	Examiner	Art Unit
	Tai Van Nguyen	3729

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,523,122	06-1985	Tone et al.	310/334
	B	US-5,242,652	09-1993	Savigny, Francois	264/510
	C	US-5,114,803	05-1992	Ishihara et al.	429/30
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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